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Sheet 1 of 1	

Substitute Form PTO-1449 (Modified) U.S. Department of Commerce Patent and Trademark Office			Application No. 09/752,817	
b	Disclosure Statement / Applicant	Applicant Shunpei Yamazaki et al		-
(Use seve (37 CFR 81 98/h))	al sheets if necessary)	Filing Date January 3, 2001	Group Art Unit	

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Substitute Form PTO-1449 U.S. Department of Commerce (Modified) Patent and Trademark Office			Application No. Unknown
by A	closure Statement oplicant	Applicant Shunpei Yamazaki e	et al.
(Use several st	neets if necessary)	Filing Date January 3, 2001	Group Art Unit Unknown

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